

# ESJ200SH60FA

## High Power IGBT Module(FST)

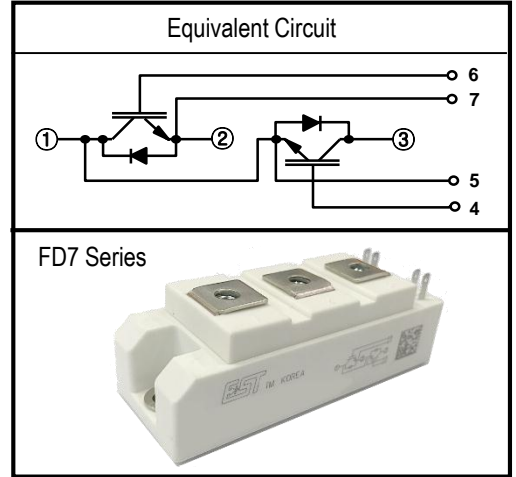
### Features

- $BV_{CES} = 650V$
- Low Conduction Loss :  $V_{CE(sat)} = 1.65V$  (typ.)
- Fast & Soft Anti-Parallel FWD
- Reduced EMI and RFI
- Isolation Type Package

### Applications

- Welding Machine
- Induction Heating
- UPS

### Equivalent Circuit and Package



Please see the package out line information

### Absolute Maximum Ratings @ $T_c=25^\circ C$ (Per Leg)

Symbol	Parameter	Conditions	Ratings	Unit
$V_{CES}$	Collector-emitter voltage	-	650	V
$V_{GES}$	Gate-emitter peak voltage	-	$\pm 20$	V
$I_C$	DC-collector current	$T_C = 25^\circ C$	400	A
		$T_C = 80^\circ C$	200	A
$I_{CM}^{(1)}$	Repetitive peak collector current	1ms	400	A
$I_F$	Diode continuous forward current	$T_C = 80^\circ C$	200	A
$I_{FM}$	Diode repetitive peak forward current	-	400	A
$T_J^{(2)}$	Operating junction temperature	-	-40 ~ 125	$^\circ C$
$T_{stg}$	Storage temperature range	-	-40 ~ 125	$^\circ C$
$V_{ISO}$	Insulation test voltage	60Hz, $t=1min$ , $I_{ISOL}=1mA$	2.5	kV
$M_S$	Mounting screw torque	M6	3.0 ~ 6.0	N.m
$M_t$	Mounting terminals screw torque	M5	2.5 ~ 5.0	N.m

(Note \*1) Repetitive rating : Pulse width limited by max junction temperature

(Note \*2) The maximum junction temperature of chip is  $150^\circ C$

**Electrical Characteristics of IGBT @  $T_c=25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit	
$BV_{CES}$	C - E Breakdown Voltage	$V_{GE} = 0V, I_C = 1mA$	650	-	-	V	
$V_{GE(th)}$	G-E threshold voltage	$I_C = 10mA, V_{CE} = V_{GE}$	5.0	-	7.0	V	
$I_{CES}$	Zero gate voltage collector current	$V_{GE} = 0V, V_{CE} = 600V$	-	-	100	$\mu A$	
$I_{GES}$	G-E leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$	-	-	$\pm 0.2$	$\mu A$	
$R_{int}$	Internal Gate resistor	-	-	0.9	-	$\Omega$	
$V_{CE(Sat)}$	C-E saturation voltage	$I_C = 200A, V_{GE} = 15V, T_j = 25^\circ\text{C}$	-	1.65	2.0	V	
		$I_C = 200A, V_{GE} = 15V, T_j = 125^\circ\text{C}$	-	2.0	-	V	
$C_{ies}$	Input capacitance	$V_{GE} = 0V, f = 1MHz, V_{CE} = 25V$	-	11320	-	pF	
$C_{oes}$	Output capacitance		-	845	-		
$C_{res}$	Reverse transfer capacitance		-	128	-		
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 300V, I_C = 200A,$ $V_{GE} = \pm 15V, R_G = 10\Omega,$ $T_j = 25^\circ\text{C},$ Inductive load	-	165	-	nS	
$t_r$	Turn-on rise time		-	160	-		
$t_{d(off)}$	Turn-off delay time		-	275	-		
$t_f$	Turn-off fall time		-	95	-		
$E_{on}$	Turn-on Energy loss		-	1.35	-		mJ
$E_{off}$	Turn-off Energy loss		-	9.35	-		
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 300V, I_C = 200A,$ $V_{GE} = \pm 15V, R_G = 10\Omega,$ $T_j = 125^\circ\text{C},$ Inductive load	-	165	-	nS	
$t_r$	Turn-on rise time		-	160	-		
$t_{d(off)}$	Turn-off delay time		-	300	-		
$t_f$	Turn-off fall time		-	105	-		
$E_{on}$	Turn-on Energy loss		-	1.90	-		mJ
$E_{off}$	Turn-off Energy loss		-	10.1	-		
$T_{sc}$	Short Circuit Withstand Time	$V_{CC} = 300V, V_{GE} = 15V, R_G = 100\Omega$	10	-	-	$\mu S$	
$Q_g$	Total gate charge	$V_{GE} = \pm 15V, V_{CE} = 300V, I_C = 200A$	-	500	-	nC	

**Electrical Characteristics of FRD @ T<sub>c</sub>=25°C (unless otherwise specified)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit	
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> =200A	T <sub>j</sub> =25°C	-	2.5	3.2	V
			T <sub>j</sub> =125°C	-	2.7	-	
T <sub>rr</sub>	Diode Reverse Recovery Time		T <sub>j</sub> =25°C	-	100	130	nS
			T <sub>j</sub> =125°C	-	130	-	
I <sub>rr</sub>	Diode Peak Reverse Recovery Current	I <sub>F</sub> =200A, V <sub>R</sub> =300V di/dt= -1200A/uS	T <sub>j</sub> =25°C	-	60	-	A
			T <sub>j</sub> =125°C	-	70	-	
Q <sub>rr</sub>	G-E leakage current		T <sub>j</sub> =25°C	-	3000	-	nC
			T <sub>j</sub> =125°C	-	4550	-	

**Thermal Characteristics and Weight**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
R <sub>θJC</sub>	Junction-to-Case	per IGBT	-	-	0.25	°C/W
R <sub>θJC</sub>	Junction-to-Case	per DIODE	-	-	0.43	°C/W
R <sub>θCK</sub>	Case-to-Heatsink (Conductive grease applied)	per IGBT	0.05	-	-	°C/W
Weight	Weight of Module		-	-	160	g

## Performance Curves

Fig. 1 Typical IGBT output characteristics ( $T_J = 25^\circ\text{C}$ )

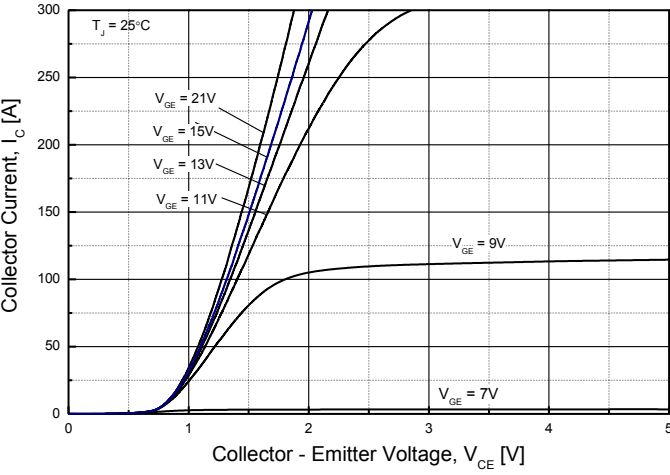


Fig. 2 Typical IGBT output characteristics ( $T_J = 125^\circ\text{C}$ )

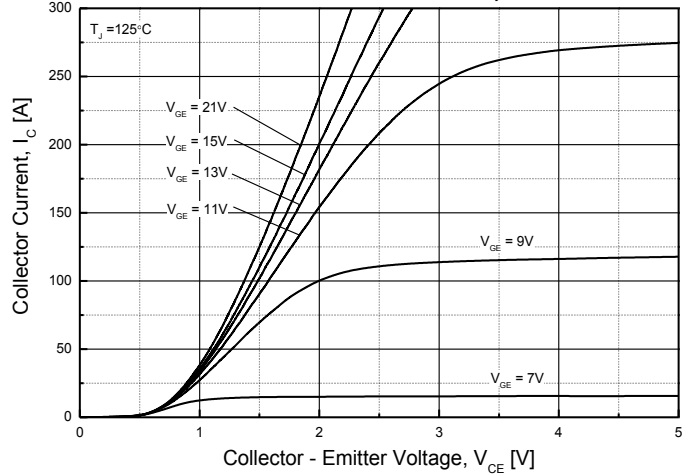


Fig. 3 Typical IGBT output characteristics

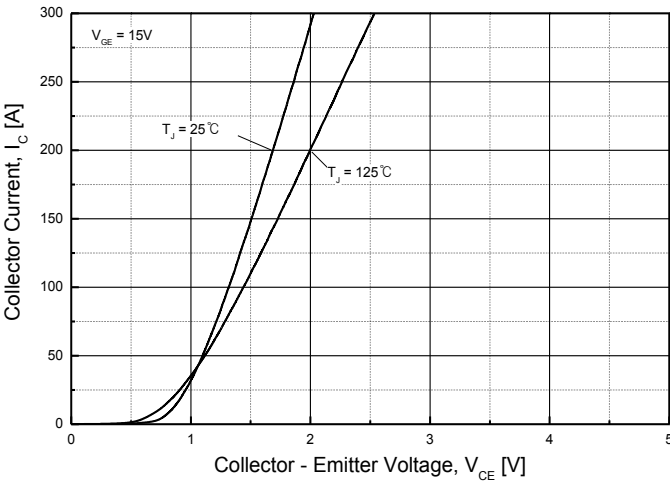


Fig. 4 Typical diode forward characteristics

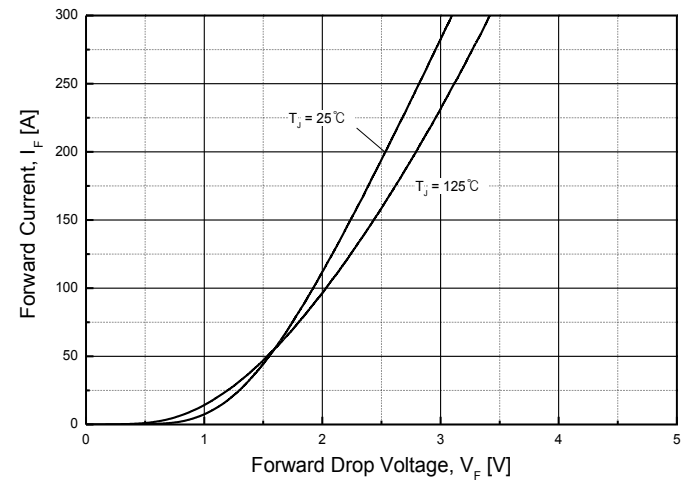


Fig. 5 Typical Switching Energy Loss =  $f(R_G)$   
 $V_{GE} = \pm 15\text{V}$ ,  $I_C = 200\text{A}$ ,  $V_{CE} = 300\text{V}$ ,  $T_J = 25^\circ\text{C}$

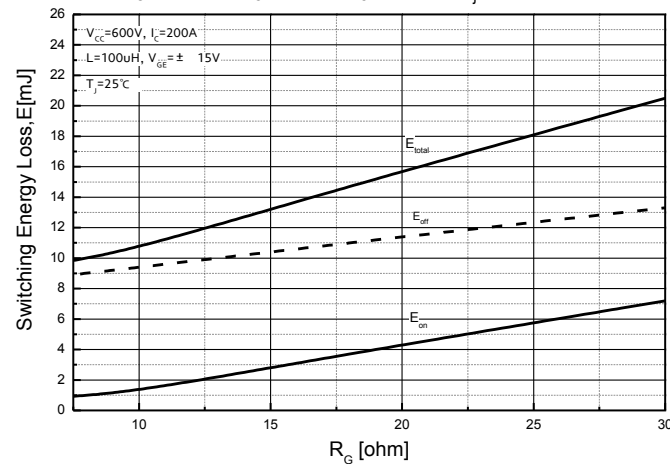
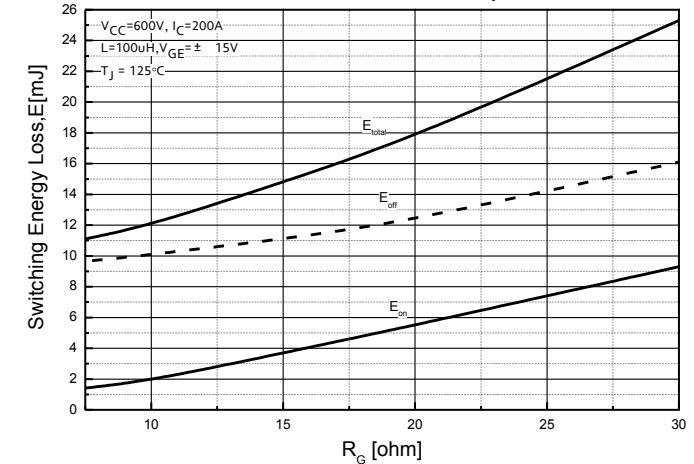


Fig. 6 Typical Switching Energy Loss =  $f(R_G)$   
 $V_{GE} = \pm 15\text{V}$ ,  $I_C = 200\text{A}$ ,  $V_{CE} = 300\text{V}$ ,  $T_J = 125^\circ\text{C}$



## Performance Curves

Fig. 7 Typical Switching Energy Loss =f(I<sub>c</sub>)  
 $V_{GE} = \pm 15V, R_G = 5.1\Omega, V_{CE} = 300V, T_J = 25^\circ C$

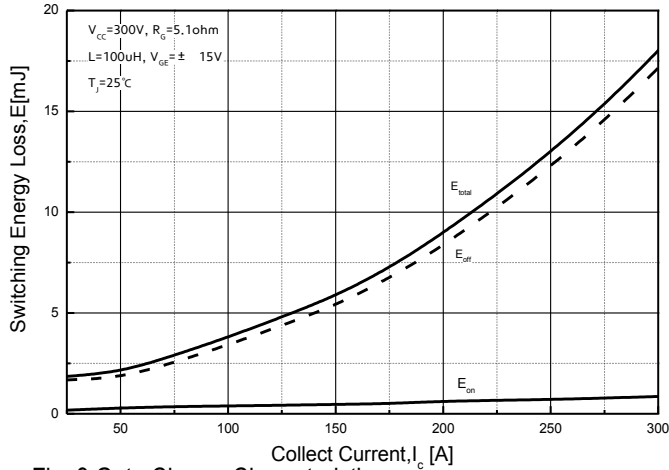


Fig. 8 Typical Switching Energy Loss =f(I<sub>c</sub>)  
 $V_{GE} = \pm 15V, R_G = 5.1\Omega, V_{CE} = 300V, T_J = 125^\circ C$

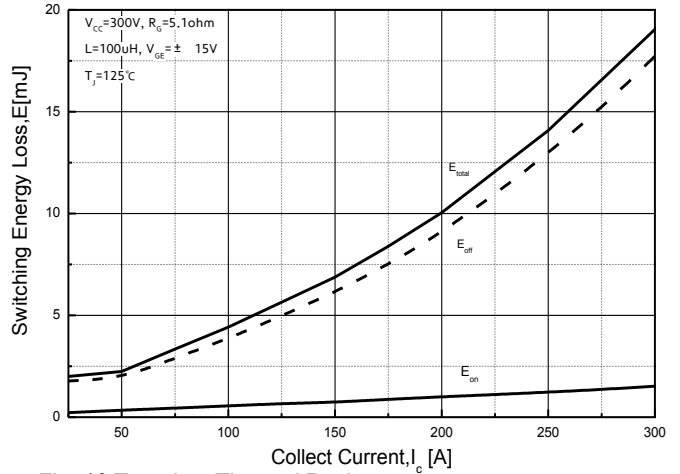


Fig. 9 Gate Charge Characteristics

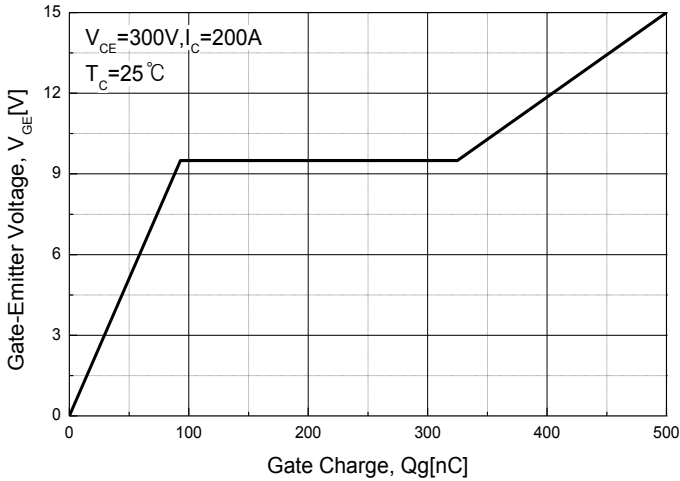
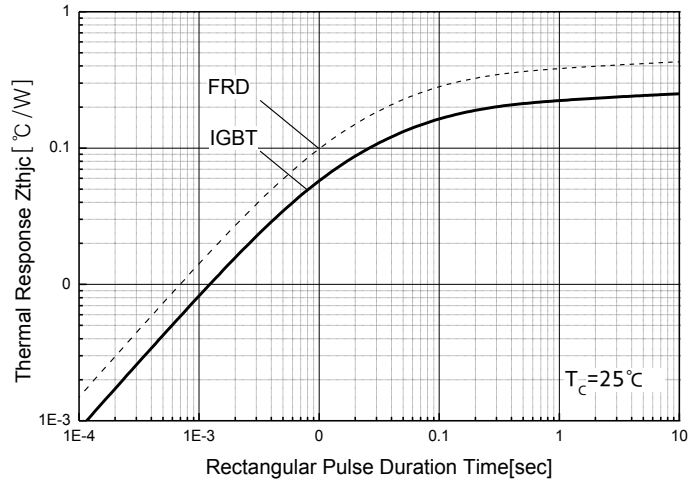


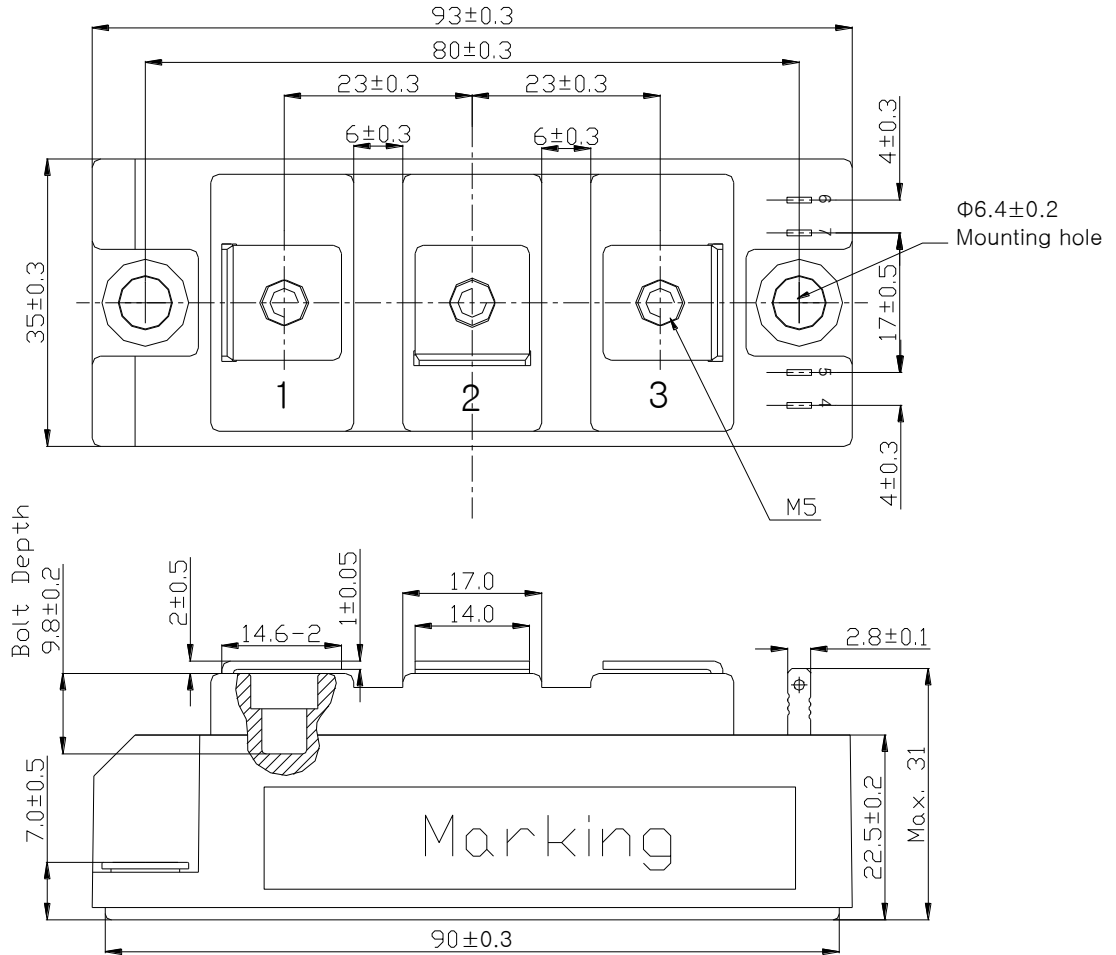
Fig. 10 Transient Thermal Resistor



■ Package Out Line Information

FD7 Package

Dimensions in mm



■ Internal Circuit

